

BTA216-600BT

Triacs high commutation

Rev. 01 — 25 August 2005

Product data sheet

1. Product profile

1.1 General description

Passivated high commutation triac in a plastic envelope. Featuring high maximum junction temperature and high commutation capability. Intended for use in circuits where high static and dynamic dV/dt and high dl/dt can occur. This device will commutate the full rated RMS current at the maximum rated junction temperature, without the aid of a snubber.

1.2 Features

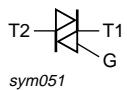
- High maximum junction temperature
- High commutation capability

1.3 Quick reference data

- | | |
|------------------------|---------------------------|
| ■ $V_{DRM} \leq 600$ V | ■ $I_{T(RMS)} \leq 16$ A |
| ■ $I_{GT} \leq 50$ mA | ■ $I_{TSM} \leq 140$ A |
| ■ $T_j \leq 150$ °C | ■ $dl_{com}/dt = 18$ A/ms |

2. Pinning information

Table 1: Pinning

Pin	Description	Simplified outline	Symbol
1	main terminal 1 (T1)		
2	main terminal 2 (T2)		
3	gate (G)		
mb	mounting base	[1]	 sym051

[1] Connected to main terminal 2 (T2)

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3. Ordering information

Table 2: Ordering information

Type number	Package			Version
	Name	Description		
BTA216-600BT	TO-220AB	plastic single-ended package; heatsink mounted; 3 leads; 1 mounting hole		SOT78

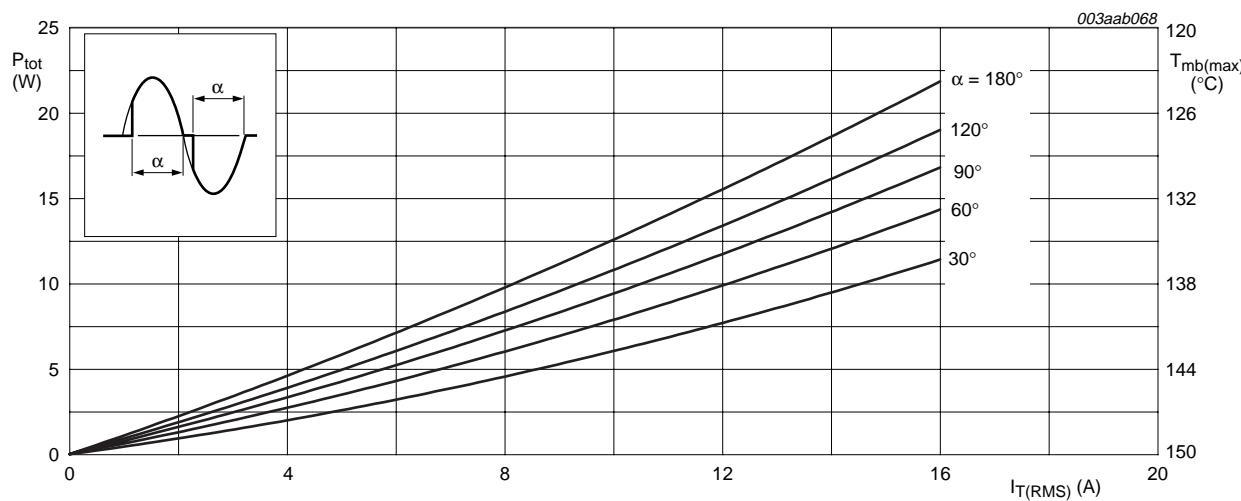
4. Limiting values

Table 3: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

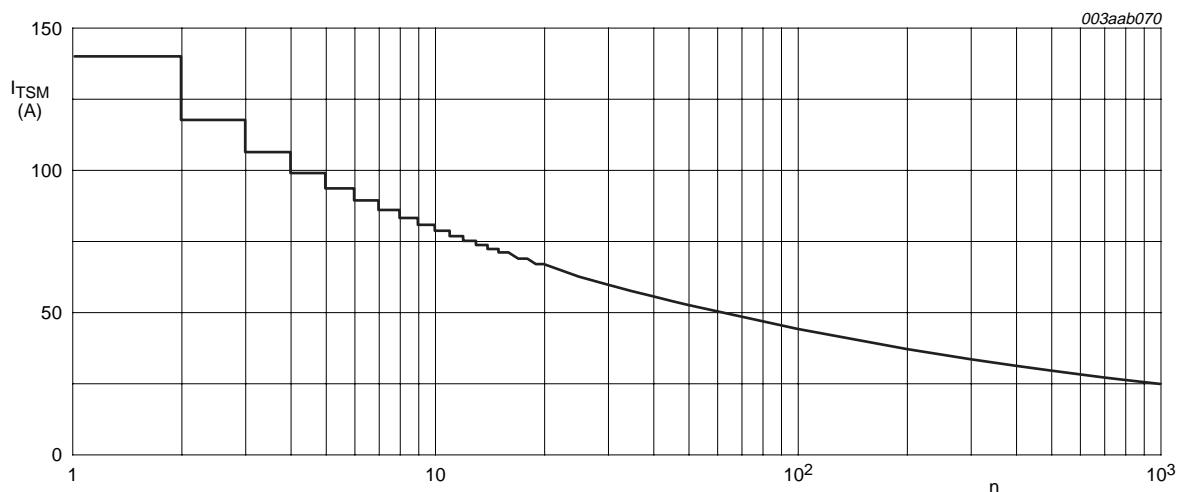
Symbol	Parameter	Conditions	Min	Max	Unit
V_{DRM}	repetitive peak off-state voltage		[1]	-	V
$I_{T(RMS)}$	RMS on-state current	full sine wave; $T_{mb} \leq 124^\circ\text{C}$; see Figure 4 and 5	-	16	A
I_{TSM}	non-repetitive peak on-state current	full sine wave; $T_j = 25^\circ\text{C}$ prior to surge; see Figure 2 and 3			
		$t = 20\text{ ms}$	-	140	A
		$t = 16.7\text{ ms}$	-	150	A
I^2t	I^2t for fusing	$t = 10\text{ ms}$	-	98	A^2s
dI_T/dt	rate of rise of on-state current	$I_{TM} = 20\text{ A}$; $I_G = 0.2\text{ A}$; $dI_G/dt = 0.2\text{ A}/\mu\text{s}$	-	100	$\text{A}/\mu\text{s}$
I_{GM}	peak gate current		-	2	A
V_{GM}	peak gate voltage		-	5	V
P_{GM}	peak gate power		-	5	W
$P_{G(AV)}$	average gate power	over any 20 ms period	-	0.5	W
T_{stg}	storage temperature		-40	+150	$^\circ\text{C}$
T_j	junction temperature		-	150	$^\circ\text{C}$

[1] Although not recommended, off-state voltages up to 800 V may be applied without damage, but the triac may switch to the on-state. The rate of rise of current should not exceed 15 A/ μs .



α = conduction angle

Fig 1. On-state power dissipation as a function of RMS on-state current; maximum values



$f = 50$ Hz

Fig 2. Non-repetitive peak on-state current as a function of number of half cycles; sinusoidal currents; maximum values

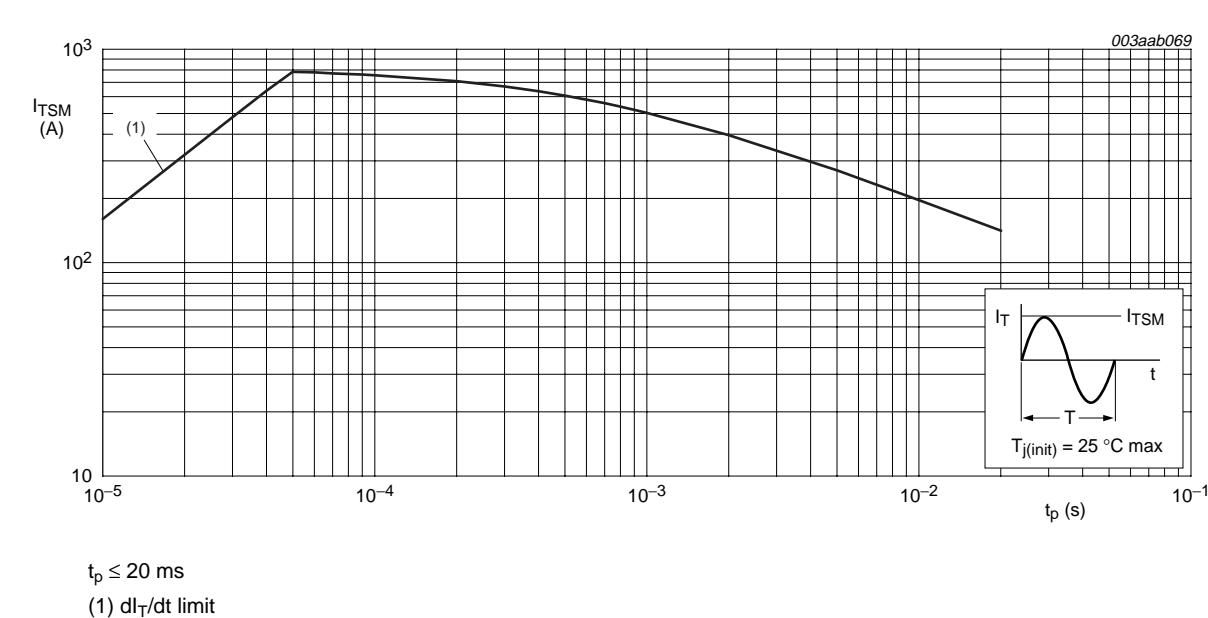


Fig 3. Non-repetitive peak on-state current as a function of pulse width; sinusoidal currents; maximum values

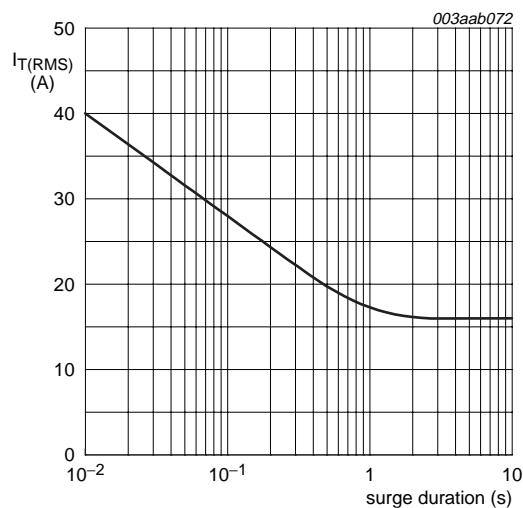


Fig 4. RMS on-state current as a function of surge duration; sinusoidal currents; maximum values

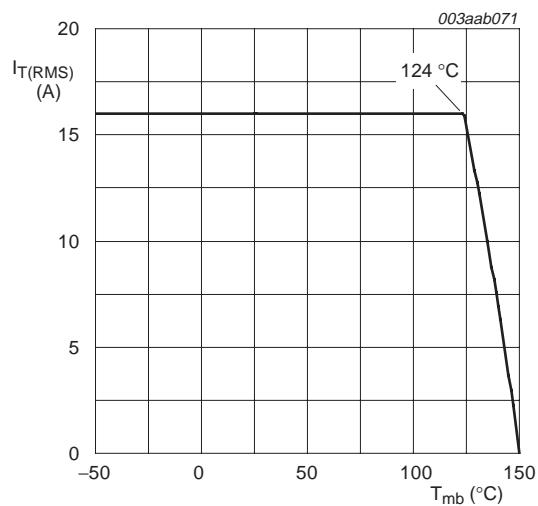


Fig 5. RMS on-state current as a function of mounting base temperature; maximum values

5. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	full cycle; see Figure 6	-	-	1.2	K/W
		half cycle; see Figure 6	-	-	1.7	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	-	60	-	K/W

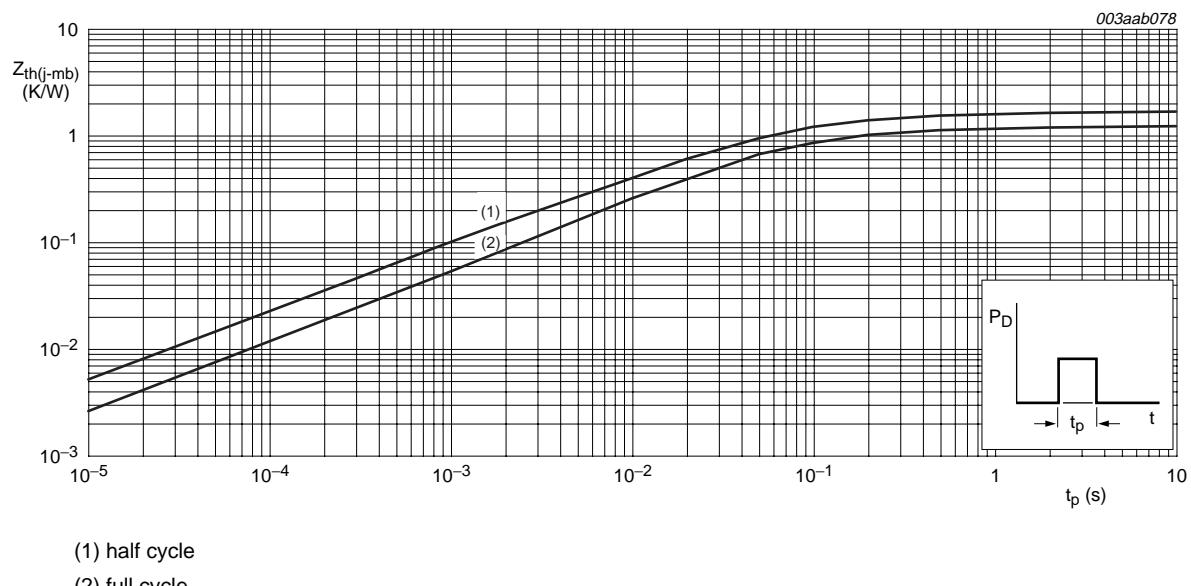


Fig 6. Transient thermal impedance from junction to mounting base as a function of pulse width



6. Static characteristics

Table 5: Static characteristics $T_j = 25^\circ\text{C}$ unless otherwise specified.

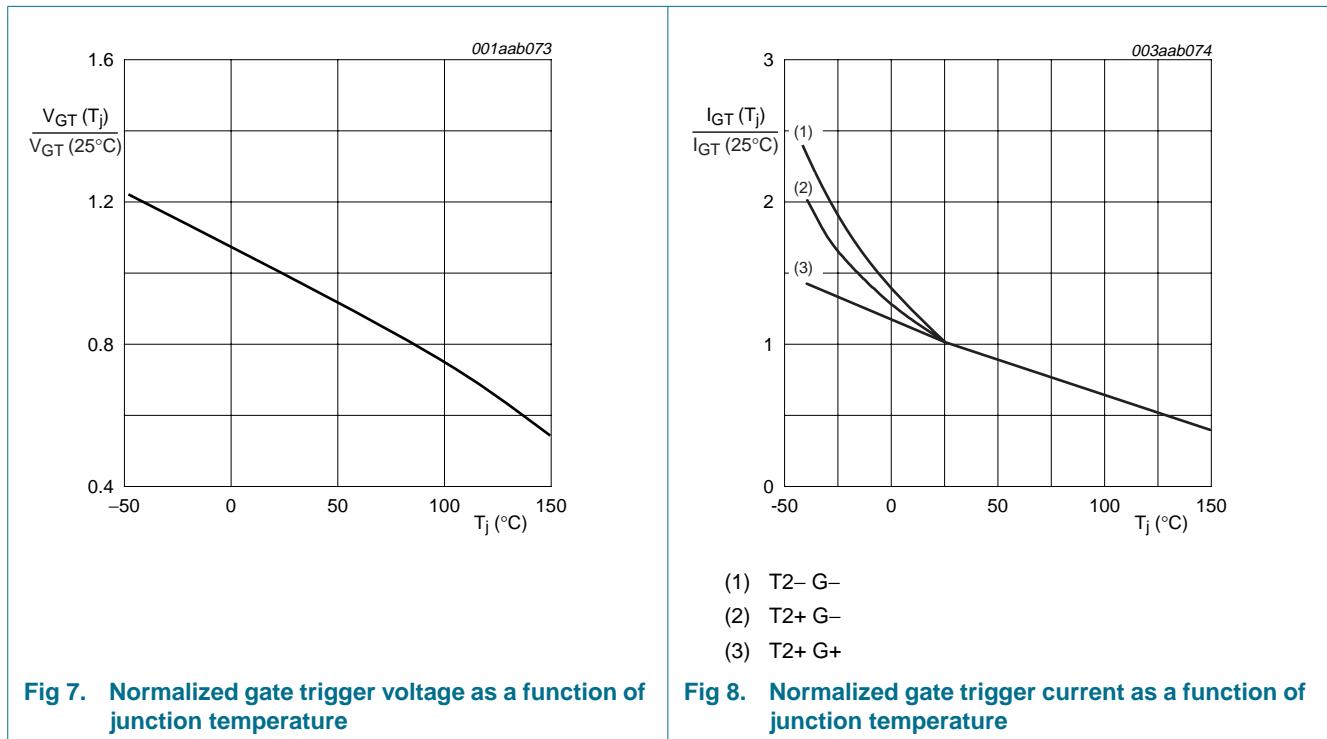
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
I_{GT}	gate trigger current	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}$; see Figure 8	[1]			
		T2+ G+	2	18	50	mA
		T2+ G-	2	21	50	mA
		T2- G-	2	34	50	mA
I_L	latching current	$V_D = 12 \text{ V}; I_{GT} = 0.1 \text{ A}$; see Figure 10				
		T2+ G+	-	31	60	mA
		T2+ G-	-	34	90	mA
		T2- G-	-	30	60	mA
I_H	holding current	$V_D = 12 \text{ V}; I_{GT} = 0.1 \text{ A}$; see Figure 11	-	31	60	mA
V_T	on-state voltage	$I_T = 20 \text{ A}$; see Figure 9	-	1.2	1.5	V
V_{GT}	gate trigger voltage	$V_D = 12 \text{ V}; I_T = 0.1 \text{ A}$; see Figure 7	-	0.7	1.5	V
		$V_D = 400 \text{ V}; I_T = 0.1 \text{ A}; T_j = 150^\circ\text{C}$	0.25	0.4	-	V
I_D	off-state current	$V_D = V_{DRM(\max)}; T_j = 150^\circ\text{C}$	-	0.5	3	mA

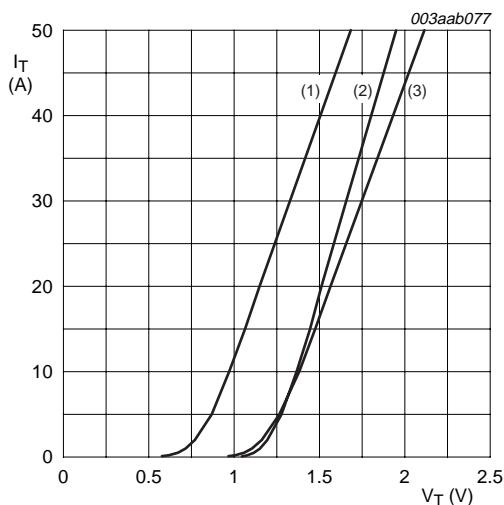
[1] Device does not trigger in the T2- G+ quadrant.

7. Dynamic characteristics

Table 6: Dynamic characteristics $T_j = 25^\circ\text{C}$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
dV_D/dt	rate of rise of off-state voltage	$V_{DM} = 0.67V_{DRM(max)}$; $T_j = 150^\circ\text{C}$; exponential waveform; gate open circuit	500	1500	-	$\text{V}/\mu\text{s}$
dl_{com}/dt	rate of change of commutating current	$V_{DM} = 400 \text{ V}$; $T_j = 150^\circ\text{C}$; $I_{T(RMS)} = 16 \text{ A}$; without snubber; gate open circuit; see Figure 12	9	18	-	A/ms
t_{gt}	gate-controlled turn-on time	$I_{TM} = 20 \text{ A}$; $V_D = V_{DRM(max)}$; $I_G = 0.1 \text{ A}$; $dl_G/dt = 5 \text{ A}/\mu\text{s}$	-	2	-	μs

**Fig 7. Normalized gate trigger voltage as a function of junction temperature****Fig 8. Normalized gate trigger current as a function of junction temperature**



$V_O = 1.195 \text{ V}; R_S = 18 \text{ m}\Omega$
(1) $T_j = 150^\circ\text{C}$; typical values
(2) $T_j = 25^\circ\text{C}$; maximum values
(3) $T_j = 150^\circ\text{C}$; maximum values

Fig 9. On-state characteristic

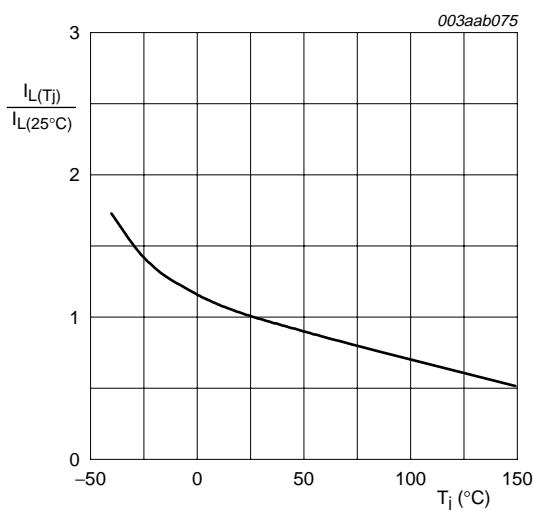


Fig 10. Normalized latching current as a function of junction temperature

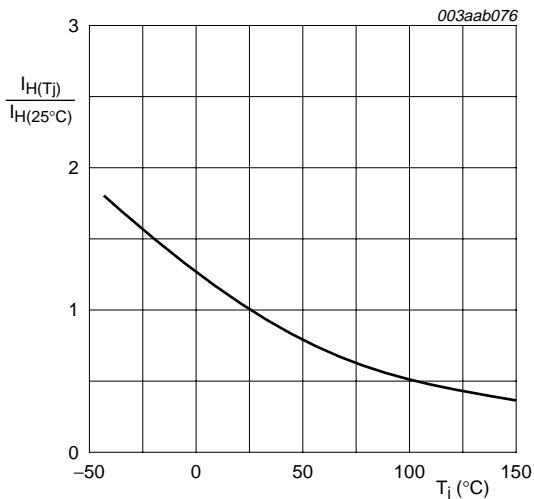


Fig 11. Normalized holding current as a function of junction temperature

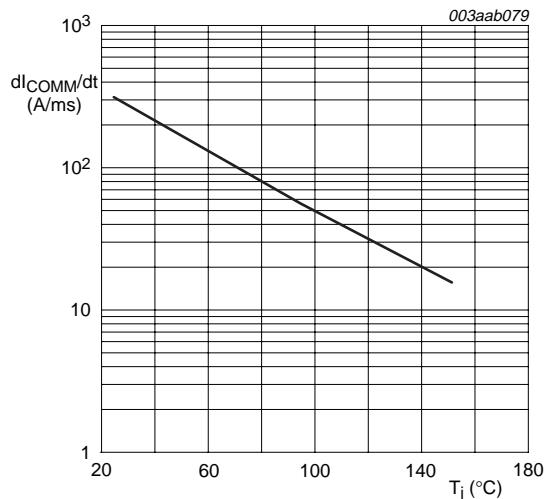


Fig 12. Rate of change of commuting current as a function of junction temperature; typical values

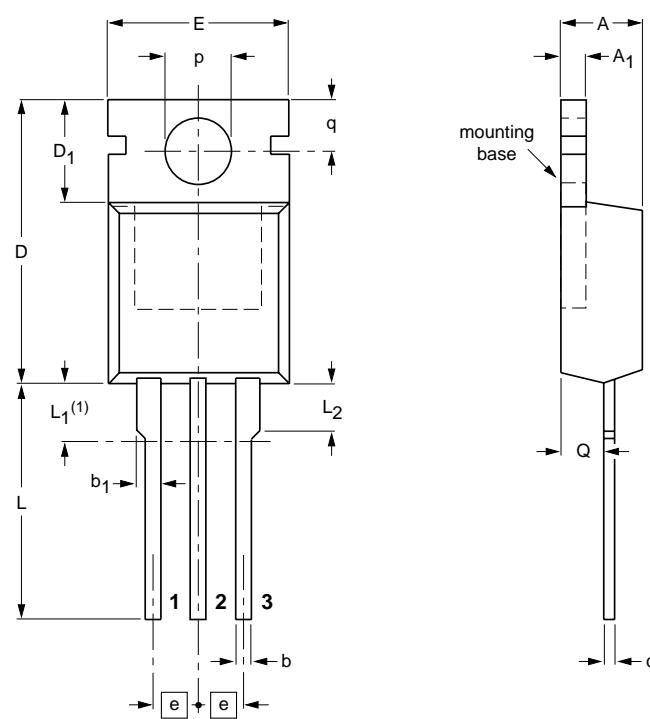
8. Package information

Plastic meets UL94 V-0 at $1/8$ inch.

9. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

SOT78



0 5 10 mm
scale

DIMENSIONS (mm are the original dimensions)

UNIT	A	A ₁	b	b ₁	c	D	D ₁	E	e	L	L ₁	L ₂ max.	p	q	Q
mm	4.7	1.40	0.9	1.45	0.7	16.0	6.6	10.3	2.54	15.0	3.30	3.0	3.8	3.0	2.6
	4.1	1.25	0.6	1.00	0.4	15.2	5.9	9.7		12.8	2.79		3.5	2.7	2.2

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT78		3-lead TO-220AB	SC-46			-05-01-31- 05-03-22

Fig 13. Package outline SOT78 (TO-220AB)



10. Revision history

Table 7: Revision history

Document ID	Release date	Data sheet status	Change notice	Doc. number	Supersedes
BTA216-600BT_1	20050825	Product data sheet	-	-	-



11. Data sheet status

Level	Data sheet status [1]	Product status [2][3]	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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16. Contents

1	Product profile	1
1.1	General description.....	1
1.2	Features	1
1.3	Quick reference data.....	1
2	Pinning information.....	1
3	Ordering information.....	2
4	Limiting values.....	2
5	Thermal characteristics.....	5
6	Static characteristics.....	6
7	Dynamic characteristics	7
8	Package information	8
9	Package outline	9
10	Revision history.....	10
11	Data sheet status.....	11
12	Definitions	11
13	Disclaimers.....	11
14	Trademarks.....	11
15	Contact information	11



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